Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/071,263	CAIA, JEAN-MICHEL	
Examiner	Art Unit	
PHUC H. TRAN	2616	

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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see histo	ry printout	10/24/2007	PT

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